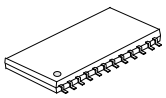
M62364

CMOS IC

8-BIT 8-CH MULTIPLYING D-A CONVERTER WITH BUFFER AMPLIFIERS



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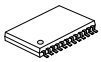


SSOP-24
(209mil)

■ DESCRIPTION

The UTC **M62364** is a CMOS 8-bit, 8-ch D/A converter having a multiplying function and output buffer amplifiers. It has a serial data input and can easily communicate with a microcontroller by the simple three-wiring method (D_{IN}, CLK, LD).

The output buffer amplifiers operating in AB-class has both sinking and driving capabilities of 1.0mA or more and can operate in a whole supply range from V_{DD} to GND.

The IC is suitable for a use in automatic adjustment applications in conjunction with a MCU by utilizing the terminal Do for a cascading connection.

■ FEATURES

*Three-wiring serial data transmission
*Doubled precision 8-ch D/A converter employing an R-2R with higher-order segment method
*8 buffer amplifiers operating in a whole supply voltage range from V_{DD} to GND
*4-quadrant multiplication

■ ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
M62364L-R24-R	M62364G-R24-R	SSOP-24	Tape Reel
M62364L-S24-R	M62364G-S24-R	SOP-24	Tape Reel

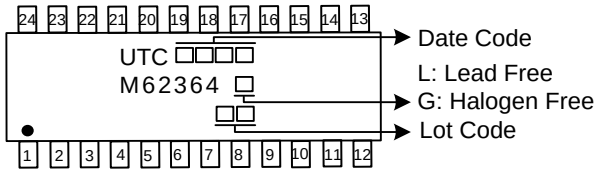
M62364G-R24-R

(1) Packing Type
(2) Package Type
(3) Green Package

(1) R: Tape Reel
(2) R24: SSOP-24, S24: SOP-24
(5) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING

SOP-24



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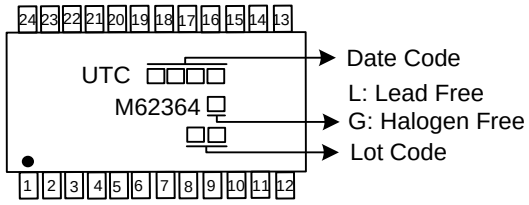
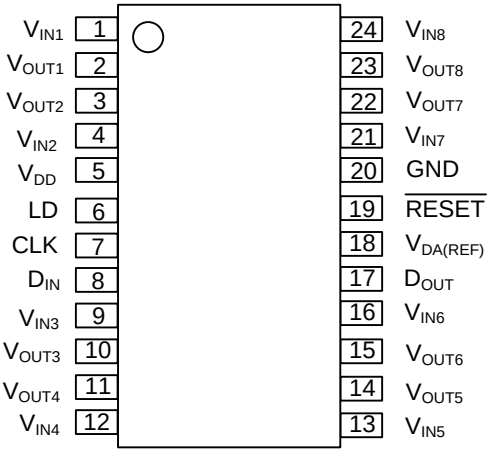


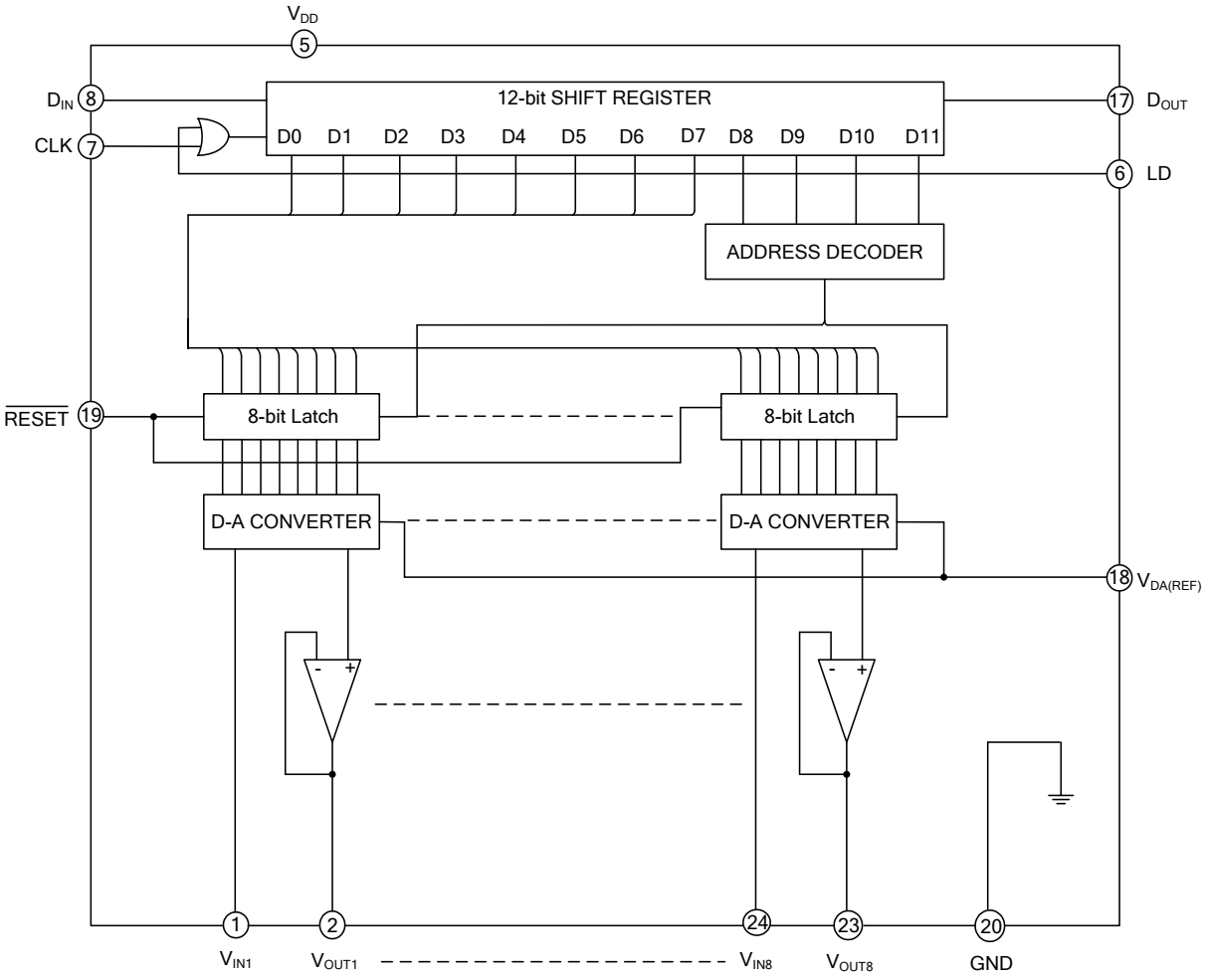
■ PIN CONFIGURATION (TOP VIEW)



■ EXPLANATION OF TERMINALS

PIN NO	SYMBOL	FUNCTION
8	D_{IN}	Serial data input
17	D_{OUT}	Serial data output
7	CLK	Shift clock input. Input data of D_{IN} are taken into the 12-bit shift register on a rising edge of the clock
6	LD	A low state enables data loading to the 12-bit shift register. During a rising edge of LD, the data will be loaded to the output register
19	$\overline{RESET}$	Reset 8-bit latches
2	V_{OUT1}	D/A Converter Output with8-bit resolution
3	V_{OUT2}	
10	V_{OUT3}	
11	V_{OUT4}	
14	V_{OUT5}	
15	V_{OUT6}	
22	V_{OUT7}	
23	V_{OUT8}	
5	V_{DD}	Power Supply
20	GND	Ground
1	V_{IN1}	D/A Converter Input
4	V_{IN2}	
9	V_{IN3}	
12	V_{IN4}	
13	V_{IN5}	
16	V_{IN6}	
21	V_{IN7}	
24	V_{IN8}	
18	$V_{DA(REF)}$	D/A Converter Reference Voltage Input

■ BLOCK DIAGRAM



■ ABSOLUTE MAXIMUM RATING

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V_{DD}	-0.3 ~ +7.0	V
Digital Input Voltage	V_{IND}	-0.3 ~ +7.0	V
Analog Input Voltage	V_{IN}	-0.3 ~ V_{DD}+0.3	V
Analog Output Voltage	V_{OUT}	-0.3 ~ V_{DD}+0.3	V
D-A Reference Voltage	$V_{DA(REF)}$	-0.3 ~ V_{DD}+0.3	V
Operating Temperature	T_{OPR}	-20 ~ +75	°C
Storage Temperature	T_{STG}	-40 ~ +125	°C

■ ELECTRICAL CHARACTERISTICS

(V_{DD}=5V±10%, V_{DD}≥V_{IN}, GND, $V_{DA(REF)}$ =0V, T_A= -20 ~ 85°C, unless otherwise specified)

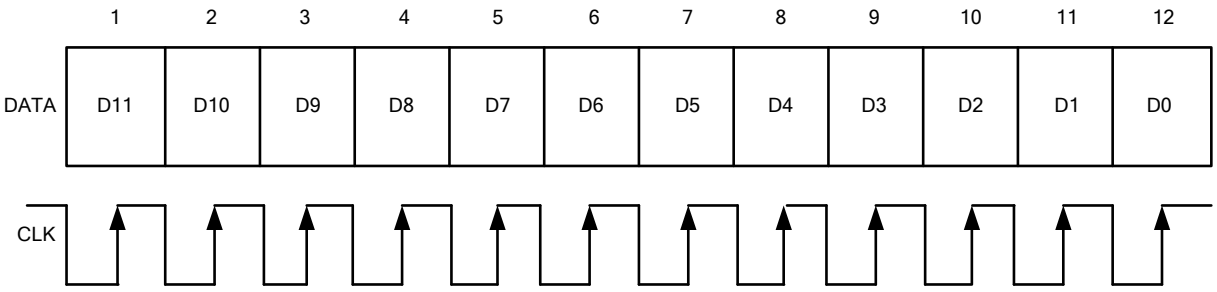
PARAMETER	SYMBOL	TEST CONDUCTION	MIN	TYP	MAX	UNIT
ANA/DIG COMMON PART						
Supply Voltage	V_{DD}		2.7	3.0		V
Supply Current	I_{DD}	CLK=1MHz, V_{CC}=3V, I_{AO}=0μA			3.5	mA
Digital Part						
Digital Input “Low” Voltage	I_{IL}				0.2 V_{DD}	V
Digital Input “High” Voltage	I_{IH}		0.8×V_{DD}			V
D_{OUT} Terminal Output “Low” Voltage	V_{OL}	I_{OL}=2.5mA			0.4	V
D_{OUT} Terminal Output “High” Voltage	V_{OH}	I_{OH}= -400μA	V_{DD} -0.8			V
Input Leak Current	I_{ILK}	V_{IN}=0 ~V_{DD}	-10		10	μA
ANALOG PART						
Buffer Amplifier Output Voltage Range	V_{AO}	I_{AO}= ±100μA	0.1		V_{CC}-0.1	V
		I_{AO}= ±500μA	0.2		V_{CC}-0.2	
Input Current	I_{IN}	V_{IN}=3V, $V_{DA(REF)}$ =0V, * Proportional to max. input current condition (V_{IN}- $V_{DA(REF)}$) and digital data of each channels.			0.18	mA
D-A Reference Input Current	$I_{DA(REF)}$	V_{IN}=3V, $V_{DA(REF)}$ =0V, * Proportional to max. input current condition (V_{IN} - $V_{DA(REF)}$) and digital data of each channels	-1.44			mA
Buffer Amplifier Output Current Range	I_{AO}	Upper Saturation Voltage=0.4V Lower Saturation Voltage=0.4V	-1		1	mA
Buffer Amplifier Output Impedance	R_O			5		Ω
Resolution	RES	V_{DD}=2.61V,$V_{DA(REF)}$ =0.050V (10mV/1LSB) Without Load (I_{AO}= ±0)		8		bit
Differential Nonlinearity	DNL		-1		1	LSB
Nonlinearity	NL		-1.5		1.5	LSB
Output Capacitative Load	C_O				0.1	μF

■ ELECTRICAL CHARACTERISTICS(Cont.)

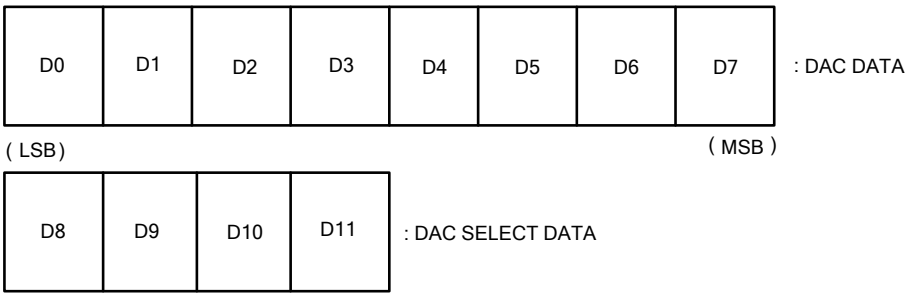
PARAMETER	SYMBOL	TEST CONDUCTION	MIN	TYP	MAX	UNIT
AC CHARACTERISTICS						
Clock “L” Pulse Width	t_{CKL}		200			ns
Clock “H” Pulse Width	t_{CKH}		200			ns
Clock Rise Time	t_{CR}				200	ns
Clock Fall Time	t_{CF}					
Data Set Up Time	t_{DCH}		60			ns
Data Hold Time	t_{CHD}		100			ns
LD Set Up Time	t_{CHL}		200			ns
LD Hold Time	t_{LDC}		100			ns
LD “H” Pulse Duration Time	t_{LDH}		100			ns
Data Output Delay Time	t_{DOUT}	C_L=100pF	70		350	ns
D-A Output Setting Time	t_{LDD}	C_L≤100pF,V_{AO} : 0.1<=>2.6V This Time Until The Output Becomes The final Value Of 1/2 LSB			300	μs

■ DIGITAL FORMAT

12 BIT SERIAL DATA (LSB)



DATA ASSIGNMENT



Dac Select Data

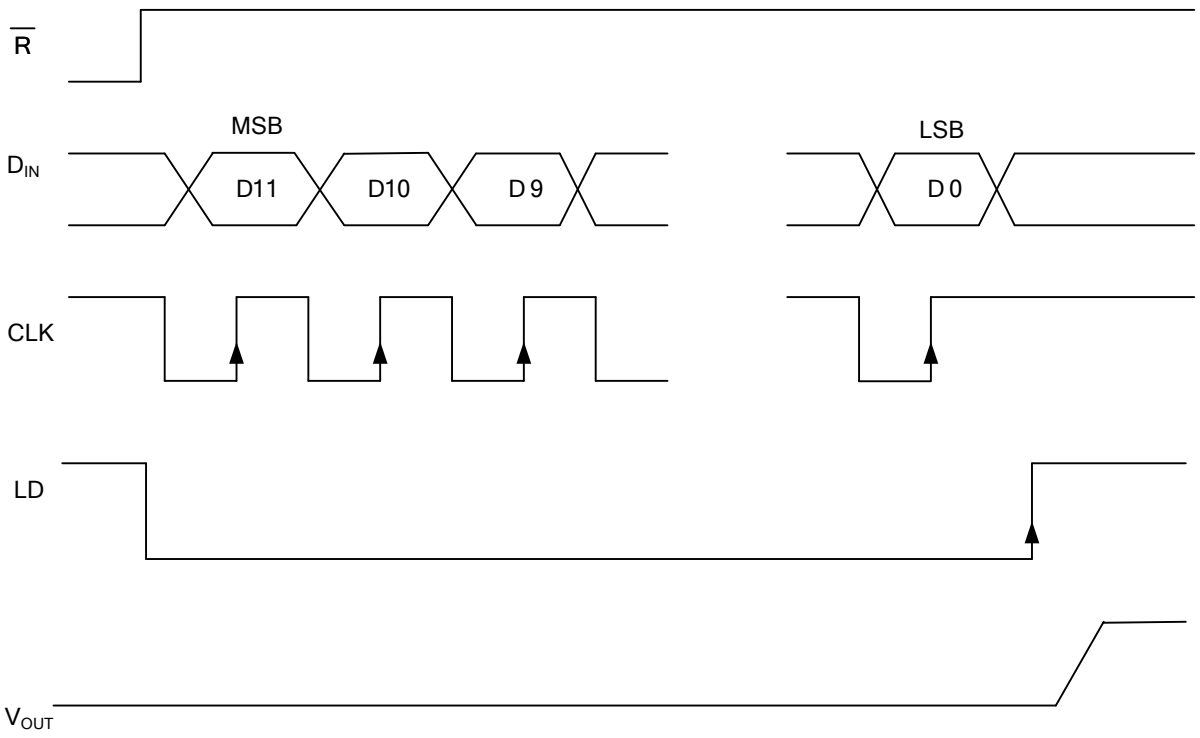
D8	D9	D10	D11	Dac Selection
0	0	0	0	Don't Care
0	0	0	1	V_{OUT1} Selection
0	0	1	0	V_{OUT2} Selection
0	0	1	1	V_{OUT3} Selection
0	1	0	0	V_{OUT4} Selection
0	1	0	1	V_{OUT5} Selection
0	1	1	0	V_{OUT6} Selection
0	1	1	1	V_{OUT7} Selection
1	0	0	0	V_{OUT8} Selection
1	0	0	1	Don't Care
1	0	1	0	Don't Care
1	0	1	1	Don't Care
1	1	0	0	Don't Care
1	1	0	1	Don't Care
1	1	1	0	Don't Care
1	1	1	1	Don't Care

■ DIGITAL FORMAT(Cont.)

Digital Data Format

D0	D1	D2	D3	D4	D5	D6	D7	DAC OUTPUT
0	0	0	0	0	0	0	0	$V_{DA(REF)}$
1	0	0	0	0	0	0	0	$(V_{IN}-V_{DA(REF)})$ /256×1+$V_{DA(REF)}$
0	1	0	0	0	0	0	0	$(V_{IN}-V_{DA(REF)})$ /256×2+$V_{DA(REF)}$
1	1	0	0	0	0	0	0	$(V_{IN}-V_{DA(REF)})$ /256×3+$V_{DA(REF)}$
⋮	⋮	⋮	⋮	⋮	⋮	⋮	⋮	
1	1	1	1	1	1	1	1	$(V_{IN}-V_{DA(REF)})$ /256×255+$V_{DA(REF)}$

■ TIMING CHART



* Input data carried out LD signal Low besides CLK signal positive edge.
CLK,LD is keep generally HIGH level.

■ TIMING CHART (Cont.)